Notice of References Cited Application/Control No. 10/689,108 Examiner Alexandra K Pechhold Applicant(s)/Patent Under Reexamination BLANKENSHIP ET AL. Page 1 of 1

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.